

<b>Notice of References Cited</b>	Application/Control No. 10/051,845	Applicant(s)/Patent Under Reexamination CARTER ET AL.	
	Examiner Yelena G. Gakh, Ph.D.	Art Unit 1743	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,861,262	03-2005	Novinski et al.	436/111
	B	US-2002/0160439	10-2002	Anne et al.	435/25
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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